Search Notes



Application/Control N	No.
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Applicant(s)/Patent under Reexamination

BAVANT ET AL.

09/895,324 Examiner

Art Unit

Habte Mered

2616

	SEARCHED			
Class	Subclass	Date	Examiner	
709	238- 244(Text search updated)	5/12/2006	нм	
370	395.53	5/12/2006	НМ	
370	395.554	5/12/2006	НМ	
370	389-401	5/12/2006	нм	
370	474-475	5/12/2006	НМ	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	395.53	5/13/2006	нм	
370	395.54	5/13/2006	нм	
370	400	5/13/2006	НМ	
5/13/20 interferen	ext search 06, see ce search port	5/13/2006	нм	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Palm Inventor Search	5/12/2006	НМ	
Searched IEEE	5/12/2006	НМ	
Searched EAST DB:USPG-PUB, USPAT, EPO, and JPO	5/12/2006	НМ	
Consulted with SPE (Hassan Kizou) on allowable subject matter	5/11/2006	НМ	